



TEST REPORT

No.I20N01075-HAC RF

For

TCL Communication Ltd.

LTE/UMTS/GSM mobile phone

Model Name: 5002R

With

Hardware Version: 03

Software Version: GZ2LUDL0

FCC ID: 2ACCJH124

Results Summary: M Category = M4

Issued Date: 2020-06-18

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of SAICT.

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REPORT HISTORY

Report Number	Revision	Description	Issue Date
I20N01075-HAC RF	Rev.0	1st edition	2020-06-18





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1. Summary of Test Report

1.1. Test Items

Description	LTE/UMTS/GSM mobile phone
Model Name	5002R
Applicant's name	TCL Communication Ltd.
Manufacturer's Name	TCL Communication Ltd.

1.2. Test Standards

ANSI C63.19-2011

1.3. Test Result

Pass

1.4. Testing Location

Address: Building G, Shenzhen International Innovation Center, No.1006 Shennan Road, Futian District, Shenzhen, Guangdong, P. R. China 518026

1.5. Project Data

Testing Start Date: 2019-05-11

Testing End Date: 2020-05-11

1.6. Signature

Li Yongfu (Prepared this test report)

Cao Junfei (Approved this test report)

Zhang Yunzhuan (Reviewed this test report)

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2. Client Information

2.1. Applicant Information

Company Name:	TCL Communication Ltd.	
Address:	5/F, Building 22E, 22 Science Park East Avenue, Hong Kong Science	
Address:	Park, Shatin, NT, Hong Kong	
City:	/	
Country:	/	
Telephone:	0086-755-36611722	

2.2. Manufacturer Information

Company Name:	TCL Communication Ltd.
Address:	5/F, Building 22E, 22 Science Park East Avenue, Hong Kong Science
Address.	Park, Shatin, NT, Hong Kong
City:	1
Country:	/
Telephone:	0086-755-36611722





3. Equipment under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description:	LTE/UMTS/GSM mobile phone
Model name:	5002R
Condition of EUT as received:	No obvious damage in appearance
Operating mode(a):	GSM 850/1900, WCDMA Band 2/4/5
Operating mode(s):	LTE Band 2/4/5/12/14/30/66, Bluetooth, WLAN 2.4G

3.2. Internal Identification of EUT used during the test

EUT ID*	IMEI	HW Version	SW Version
UT01aa	015733000003565	03	GZ2LUDL0

*EUT ID: is used to identify the test sample in the lab internally.

Note: It is performed to test HAC with the UT01aa.

3.3. Internal Identification of AE used during the test

AE ID*	Description	Туре	Manufacturer	
AE1	Battery	TLi028C1	BYD	

*AE ID: is used to identify the test sample in the lab internally.

3.4. Air Interfaces / Bands Indicating Operating Modes

Air-interface	Band(MHz)	Туре	C63.19 / tested	Simultaneous Transmissions	Name of Voice Service	Power Reduction	
GSM	850 /1900	VO	Yes	BT,WLAN	CMRS Voice	Ne	
EDGE	850 /1900	DT	No	BT,WLAN	NA	No	
	B2 / B4/ B5	VO	Yes	BT,WLAN	CMRS Voice	No	
WCDMA	HSPA	DT	No	BT,WLAN	NA	NO	
LTE (FDD)	2/4/5/12/14/30/66	VD	Yes	BT,WLAN	VoLTE / Google duo	No	
WLAN	2.4G	VD	Yes	WWAN	VoWiFi / Google duo	No	
Bluetooth	2.4G	DT	No	WWAN	NA	No	

VO: Voice CMRS/PSTN Service Only

VD: Voice CMRS/PSTN and Data Service

DT: Digital Transport

* HAC Rating was not based on concurrent voice and data modes; Non-current mode was found to represent worst case rating for both M and T rating





4. Reference Documents

The following document listed in this section is referred for testing.

Reference	Title	Version
	American National Standard for Methods of Measurement	
ANSI C63.19-2011	of Compatibility between Wireless Communication Devices	2011
	and Hearing Aids	
KDB 285076 D01	Equipment Authorization Guidance for Hearing Aid	VOE
KDB 203070 D01	Compatibility	v05





5. Operational Conditions During Test

5.1. HAC Measurement Set-up

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core2 1.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

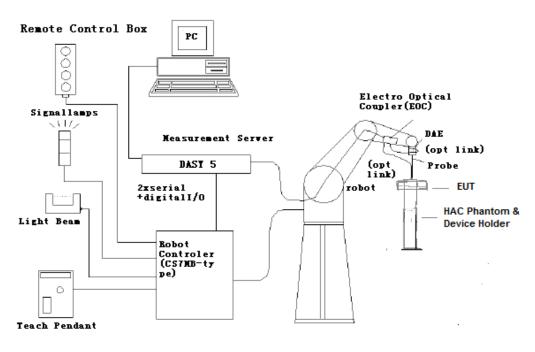


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.





5.2. Probe Specification

E-Field Probe Description

Construction Calibration	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)	A A
Frequency	40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz)	[ER3DV6]
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)	
Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB	
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm	
Application	General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms	





5.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.

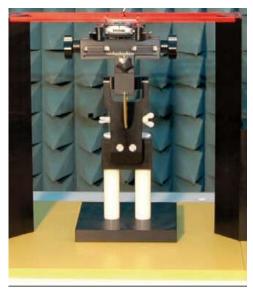


Fig. 2 HAC Phantom & Device Holder

5.4. Robotic System Specifications

Specifications

Positioner: Stäubli Unimation Corp. Robot Model: RX160XL Repeatability: ±0.02 mm No. of Axis: 6 Data Acquisition Electronic (DAE) System Cell Controller Processor: Intel Core2 Clock Speed: 1.86 GHz Operating System: Windows XP Data Converter Features:Signal Amplifier, multiplexer, A/D converter, and control logic Software: DASY5 software Connecting Lines: Optical downlink for data and status info. Optical uplink for commands and clock





6. EUT Arrangement

6.1. WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissions measurement.

• The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.

• The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).

• The grid is located by reference to a reference plane. This reference plane is the planar area that contains the highest point in the area of the WD that normally rests against the user's ear

• The measurement plane is located parallel to the reference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

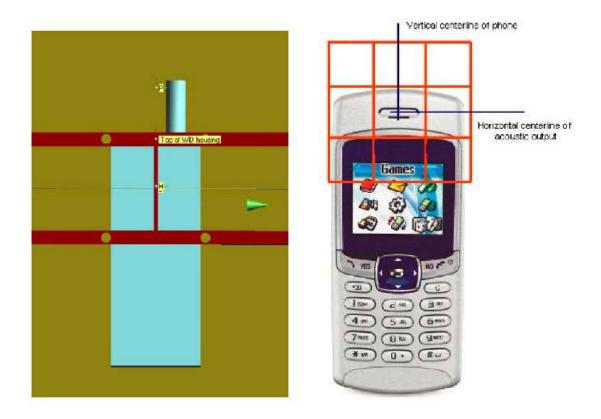


Fig. 3 WD reference and plane for RF emission measurements





7. System Validation

7.1. Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical output. Position the E-field probes so that:

• The probes and their cables are parallel to the coaxial feed of the dipole antenna

• The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions

• The center point of the probe element(s) are 15 mm from the closest surface of the dipole elements.

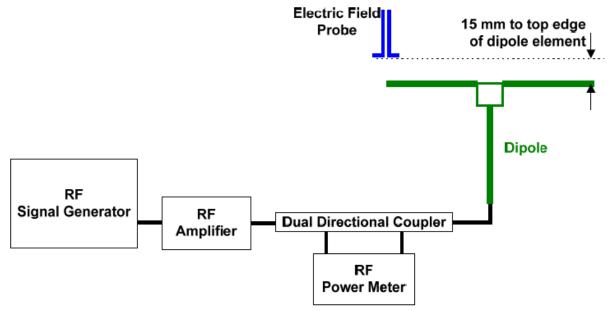


Fig. 4 Dipole Validation Setup

7.2. Validation Result

	E-Field Scan					
Mode	Frequency	Input Power	Measured ¹	Target ²	Deviation ³	Limit ⁴
wode	(MHz)	(mW)	Value(dBV/m)	Value(dBV/m)	(%)	(%)
CW	835	100	43.94	40.72	7.9	±25
CW	1880	100	39.84	39.06	2.0	±25

Notes:

1. Please refer to the attachment for detailed measurement data and plot.

2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.

3. Deviation (%) = 100 * (Measured value minus Target value) divided by Target value.

4. ANSI C63.19 requires values within \pm 25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.





8. Modulation Interference Factor (MIF)

The HAC Standard ANSI C63.19-2011 defines a new scaling using the Modulation Interference Factor (MIF) which replaces the need for the Articulation Weighting Factor (AWF) during the evaluation and is applicable to any modulation scheme.

The Modulation Interference factor (MIF, in dB) is added to the measured average E-field (in dBV/m) and converts it to the RF Audio Interference level (in dBV/m). This level considers the audible amplitude modulation components in the RF E-field. CW fields without amplitude modulation are assumed to not interfere with the hearing aid electronics. Modulations without time slots and low fluctuations at low frequencies have low MIF values, TDMA modulations with narrow transmission and repetition rates of few 100 Hz have high MIF values and give similar classifications as ANSI C63-2007.

Definitions

ER3D, E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the "indirect" measurement method according to ANSI C63.19-2011 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by probe modulation response (PMR) calibration in order to not overestimate the field reading.

The evaluation method or the MIF is defined in ANSI C63.19-2011 section D.7. An RMS demodulated RF signal is fed to a spectral filter (similar to an A weighting filter) and forwarded to a temporal filter acting as a quasi-peak detector. The averaged output of these filtering is called to a 1 kHz 80% AM signal as reference. MIF measurement requires additional instrumentation and is not well suited for evaluation by the end user with reasonable uncertainty It may alternatively be determined through analysis and simulation, because it is constraint and characteristic for a communication signal. DASY52 uses well defined signals for PMR calibration. The MIF of these signals has been determined by simulation and is automatically applied.

MIF values were not tested by a probe or as specified in the standards but are based on analysis provided by SPEAG for all the air interfaces (GSM, WCDMA, CDMA, LTE). The data included in this report are for the worst case operating modes. The UIDs used are listed below:

UID	Communication System Name	MIF (dB)
10021	GSM-FDD (TDMA, GMSK)	3.63
10011	UMTS-FDD (WCDMA)	-27.23
10170	LTE-FDD(SC-FDMA, 1RB, 20MHz, 16-QAM)	-9.76
10176	LTE-FDD(SC-FDMA, 1RB, 10MHz, 16-QAM)	-9.76
10061	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	-2.02



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A PMR calibrated probe is linearized for the selected waveform over the full dynamic range within the uncertainty specified in its calibration certificate. ER3D, EF3D and EU2D E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the \indirect" measurement method according to ANSI C63.19-2011 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by PMR calibration in order to not overestimate the field reading.

The MIF measurement uncertainty is estimated as follows, for modulation frequencies from slotted waveforms with fundamental frequency and at least 2 harmonics within 10 kHz:

0.2 dB for MIF -7 to +5 dB, 0.5 dB for MIF -13 to +11 dB 1 dB for MIF > -20 dB





9. Evaluation for low-power exemption

9.1. Product testing threshold

There are two methods for exempting an RF air interface technology from testing. The first method requires evaluation of the MIF for the worst-case operating mode. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is \leq 17 dBm for any of its operating modes. The second method does not require determination of the MIF. The RF emissions testing exemption shall be applied to an RF air interface technology in a device whose peak antenna input power, averaged over intervals \leq 50 µs20, is \leq 23 dBm. An RF air interface technology that is exempted from testing by either method shall be rated as M4.

The first method is used to be exempt from testing for the RF air interface technology in this report.

Band	power (dBm)	MIF (dB)	Sum (dBm)	HAC Test
GSM 850	33.0	3.63	36.63	Yes
GSM 1900	30.5	3.63	34.13	Yes
WCDMA B2	24.0	-27.23	-3.23	No
WCDMA B4	24.0	-27.23	-3.23	No
WCDMA B5	24.0	-27.23	-3.23	No
LTE Band 2	24.0	-9.76	14.24	No
LTE Band 4	24.0	-9.76	14.24	No
LTE Band 5	24.0	-9.76	14.24	No
LTE Band 12	24.0	-9.76	14.24	No
LTE Band 14	24.0	-9.76	14.24	No
LTE Band 30	24.0	-9.76	14.24	No
LTE Band 66	24.0	-9.76	14.24	No
WLAN 2.4G	18.0	-2.02	15.98	No

9.2. Conducted power

Note:

1. Power = Max turn-up limit





10. RF Test Procedures

The evaluation was performed with the following procedure:

- 1) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2) Position the WD in its intended test position. The gauge block can simplify this positioning.
- 3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5) Record the reading.
- 6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
- 8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)
- 9) Evaluate the MIF and add to the maximum steady-state rms field-strength reading to obtain the RF audio interference level.
- 10) Compare this RF audio interference level with the categories and record the resulting WD category rating.





11. Measurement Results (E-Field)

Frec	luency	Measured Value	Power Drift	Cotogony		
MHz	Channel	(dBV/m)	(dB)	Category		
		GSM 8	50			
848.8	251	32.24	-0.03	M4 (see Fig A.1)		
836.6	190	33.47	-0.02	M4 (see Fig A.2)		
824.2	128	34.05	-0.03	M4 (see Fig A.3)		
	GSM 1900					
1909.8	810	25.12	0.10	M4 (see Fig A.4)		
1880.0	661	25.73	0.04	M4 (see Fig A.5)		
1850.2	512	26.62	0.07	M4 (see Fig A.6)		





12. ANSI C 63.19-2011 Limits

WD RF audio interference level categories in logarithmic units

Emission categories	< 960 MHz				
<i>I</i>	E-field er	missions			
Category M1	50 to 55	dB (V/m)			
Category M2	45 to 50	dB (V/m)			
Category M3	40 to 45	dB (V/m)			
Category M4	< 40	dB (V/m)			
Emission categories	> 960	MHz			
/	E-field er	missions			
Category M1	40 to 45	dB (V/m)			
Category M2	35 to 40	dB (V/m)			
Category M3	30 to 35	dB (V/m)			
Category M4	< 30	dB (V/m)			





13. Measurement Uncertainty

No.	Error source	Туре	Uncert ainty Value (%)	Prob. Dist.	k	C _i E	Standard Uncertainty (%) $u_i^{(\%)}$ E	Degree of freedom V _{eff} or v _i	source
1	System repeatability	Α	0.24	Ν	1	1	0.24	9	Measurement
Meas	surement System								
2	Probe Calibration	В	10.1	Ν	1	1	10.1	∞	Manufacturer
3	Axial Isotropy	В	0.5	R	$\sqrt{3}$	1	0.5	8	Cal report
4	Sensor Displacement	В	16.5	R	$\sqrt{3}$	1	9.5	∞	Manufacturer
5	Boundary Effects	В	2.4	R	$\sqrt{3}$	1	1.4	∞	Manufacturer
6	Linearity	В	0.6	R	$\sqrt{3}$	1	0.35	8	Cal report
7	Scaling to Peak Envolope Power	В	2.0	R	$\sqrt{3}$	1	1.2	∞	Standard
8	System Detection Limit	В	1.0	R	$\sqrt{3}$	1	0.6	∞	Manufacturer
9	Readout Electronics	В	0.3	Ν	1	1	0.3	∞	Manufacturer
10	Response Time	В	0.8	R	$\sqrt{3}$	1	0.5	∞	Manufacturer
11	Integration Time	В	2.6	R	$\sqrt{3}$	1	1.5	∞	Manufacturer
12	RF Ambient Conditions	В	3.0	R	$\sqrt{3}$	1	1.7	∞	Measurement
13	RF Reflections	В	12.0	R	$\sqrt{3}$	1	6.9	∞	Measurement
14	Probe Positioner	А	1.2	R	$\sqrt{3}$	1	0.7	∞	Manufacturer
15	Probe Positioning	А	4.7	R	$\sqrt{3}$	1	2.7	8	Manufacturer
16	Extra. And Interpolation	В	1.0	R	$\sqrt{3}$	1	0.6	8	Manufacturer
Test	Sample Related								
17	Device Positioning Vertical	В	4.7	R	$\sqrt{3}$	1	2.7	8	Manufacturer
18	Device Positioning Lateral	В	1.0	R	$\sqrt{3}$	1	0.6	∞	Manufacturer
19	Device Holder and Phantom	В	2.4	R	$\sqrt{3}$	1	1.4	∞	Manufacturer
20	Power Drift	В	5.0	R	$\sqrt{3}$	1	2.9	∞	Measurement
Phar	Phantom and Setup related								
21	Phantom Thickness	В	2.4	R	$\sqrt{3}$	1	1.4	∞	Manufacturer
PMF	related							•	
22	Monitor amplitude	В	3.5	R	$\sqrt{3}$	1	2.02	∞	Manufacturer
23	Setup repeatability	Α	2.3	N	1	1	2.3	9	Manufacturer
24	Sensor amplitude	В	12	R	$\sqrt{3}$	1	6.93	∞	Manufacturer
	Combined standard uncertaint	y(%)		1	T		18.3		
	Expanded uncertainty (confidence interval of 95 %)	u _e	$=2u_c$	Ν	k=	=2	36.6		





14. Main Test Instruments

No.	Name	Туре	Serial Number	Calibration Date	Valid Period	
01	Signal Generator	E8257D	MY47461211	2019-06-03	One year	
02	Power meter	E4418B	MY50000366	2019-12-14		
03	Power sensor	E9304A	MY50000188	2019-12-14	One year	
04	Amplifier	VTL5400	0404	/		
05	HAC Test Arch	N/A	1150	/		
06	DAE	DAE4	1527	2019-11-11	One year	
07	E-Field Probe	ER3DV6	2424	2018-02-23	Three year	
08	HAC Dipole	CD835V3	1165	2018-07-19	Three year	
09	HAC Dipole	CD1880V3	1149	2018-07-19	Three year	
10	BTS	CMU200	114544	2019-09-02	One year	
11	Software	DASY5	52.8.8.1222	/	/	

Table 14-1: List of Main Instruments





ANNEX A: RF Emission Test Plot

HAC RF E-Field GSM 850 High

Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C Communication System: UID 0, GSM Frequency: 848.8 MHz Duty Cycle: 1:8.3 Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 28.13 V/m; Power Drift = -0.03 dB Applied MIF = 3.63 dB

RF audio interference level = 32.24 dBV/m

Emission category: M4

MIF scaled E-field	
--------------------	--

Grid 1 M4	Grid 2 M4	Grid 3 M4
33.81 dBV/m	33.62 dBV/m	32.24 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
32.26 dBV/m	32.1 dBV/m	31.19 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
31.7 dBV/m	31.34 dBV/m	30.68 dBV/m

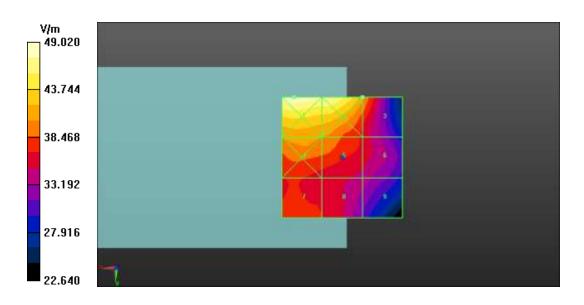


Fig A.1 HAC RF E-Field GSM850





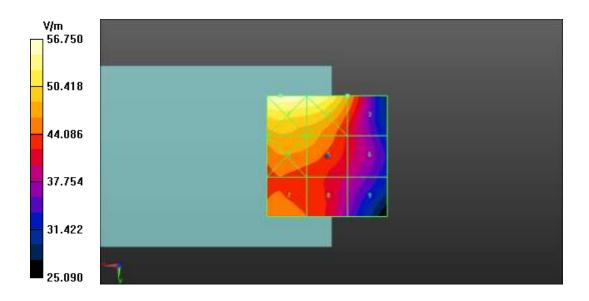
HAC RF E-Field GSM 850 Middle

Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C Communication System: UID 0, GSM Frequency: 836.6 MHz Duty Cycle: 1:8.3 Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 33.63 V/m; Power Drift = -0.02 dB Applied MIF = 3.63 dB RF audio interference level = 33.47 dBV/m Emission category: M4

Grid 1 M4	Grid 2 M4	Grid 3 M4
35.08 dBV/m	34.89 dBV/m	33.47 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
33.65 dBV/m	33.46 dBV/m	32.39 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
33.24 dBV/m	32.9 dBV/m	31.9 dBV/m









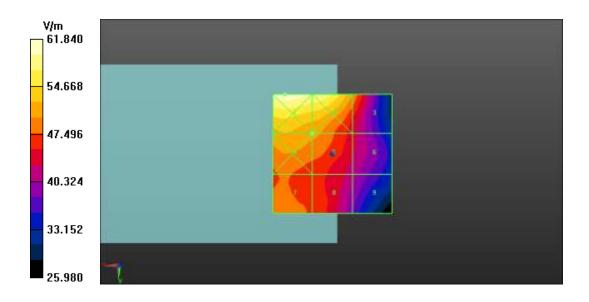
HAC RF E-Field GSM 850 Low

Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C Communication System: UID 0, GSM Frequency: 824.2 MHz Duty Cycle: 1:8.3 Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 35.92 V/m; Power Drift = -0.03 dB Applied MIF = 3.63 dB RF audio interference level = 34.05 dBV/m **Emission category: M4**

Grid 1 M4	Grid 2 M4	Grid 3 M4
35.83 dBV/m	35.53 dBV/m	33.99 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
34.35 dBV/m	34.05 dBV/m	32.82 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
33.93 dBV/m	33.44 dBV/m	32.34 dBV/m









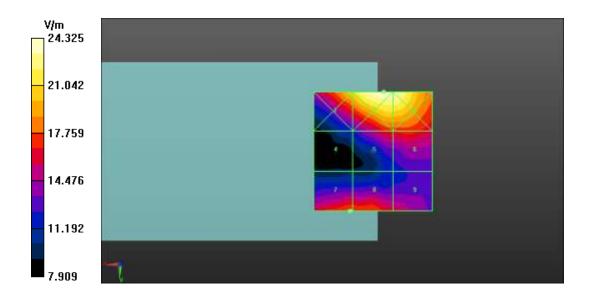
HAC RF E-Field GSM 1900 High

Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C Communication System: UID 0, GSM Frequency: 1910 MHz Duty Cycle: 1:8.3 Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 7.412 V/m; Power Drift = 0.10 dB Applied MIF = 3.63 dB RF audio interference level = 25.12 dBV/m **Emission category: M4**

Grid 1 M4	Grid 2 M4	Grid 3 M4
26.56 dBV/m	27.72 dBV/m	27.56 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
21.63 dBV/m	24.58 dBV/m	24.71 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
25.12 dBV/m	25.1 dBV/m	24.11 dBV/m









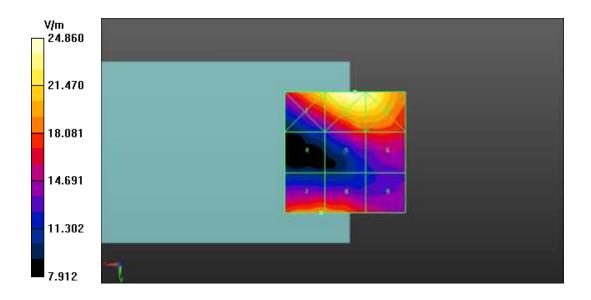
HAC RF E-Field GSM 1900 Middle

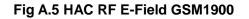
Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C Communication System: UID 0, GSM Frequency: 1880 MHz Duty Cycle: 1:8.3 Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 7.470 V/m; Power Drift = 0.04 dB Applied MIF = 3.63 dB RF audio interference level = 25.73 dBV/m **Emission category: M4**

Grid 1 M4	Grid 2 M4	Grid 3 M4
26.99 dBV/m	27.91 dBV/m	27.65 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
21.87 dBV/m	24.78 dBV/m	24.89 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
25.73 dBV/m	25.7 dBV/m	24.32 dBV/m









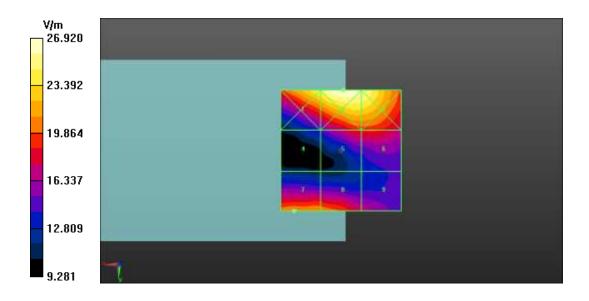
HAC RF E-Field GSM 1900 Low

Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Ambient Temperature: 22.0°C Liquid Temperature: 21.5°C Communication System: UID 0, GSM Frequency: 1850.2 MHz Duty Cycle: 1:8.3 Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 8.023 V/m; Power Drift = 0.07 dB Applied MIF = 3.63 dB RF audio interference level = 26.62 dBV/m **Emission category: M4**

Grid 1 M4	Grid 2 M4	Grid 3 M4
28.01 dBV/m	28.6 dBV/m	28.32 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
23.15 dBV/m	25.56 dBV/m	25.6 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.62 dBV/m	26.46 dBV/m	24.89 dBV/m









ANNEX B: System Validation Result

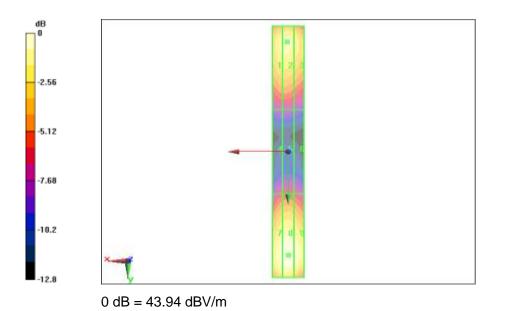
835 MHz

Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: σ = 0 mho/m, ϵ r = 1; ρ = 1000 kg/m3 Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Probe: ER3DV6 - SN2424; ConvF (1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 15mm /Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 116.2 V/m; Power Drift = 0.08 dB Applied MIF = 0.00 dB RF audio interference level = 43.94 dBV/m **Emission category: M3**

Grid 1 M3	Grid 2 M3 Grid 3 M3				
43.38 dBV/m	43.85 dBV/m 43.67 dBV/				
Grid 4 M4	Grid 5 M4	Grid 6 M4			
38.86 dBV/m	39.16 dBV/m	39.08 dBV/m			
Grid 7 M3	Grid 8 M3	Grid 9 M3			
43.44 dBV/m	43.94 dBV/m	43.73 dBV/m			



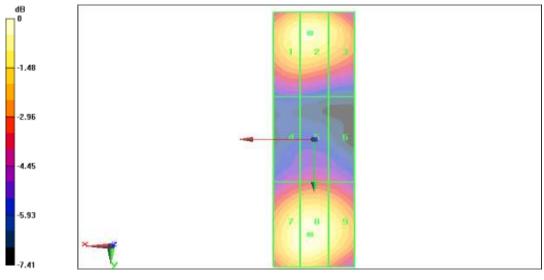




1880 MHz Date: 2019-5-11 Electronics: DAE4 Sn1527 Medium: Air Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1 Probe: ER3DV6 - SN2424; ConvF (1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 15mm /Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 139.5 V/m; Power Drift = 0.10 dB Applied MIF = 0.00 dB RF audio interference level = 39.84 dBV/m Emission category: M2

Grid 1 M2	Grid 2 M2	Grid 3 M2
39.37 dBV/m	39.84 dBV/m	39.75 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
37.79 dBV/m	37.93 dBV/m	37.88 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
39.33 dBV/m	39.79 dB V/m	39.70 dBV/m



0 dB = 39.84 dBV/m





ANNEX C: Probe Calibration Certificate

E_Probe ER3DV6

Calibration Laboratory of Schmid & Partner Engineering AG Zoughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étaipenage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Certificate No: ER3-2424_Feb18

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Accredited by the Swess Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client CTTL-SZ (Auden)

CALIBRATION CERTIFICATE Object ER3DV6 - SN:2424 Calibration procedure(s) QA CAL-02.v8, QA CAL-25.v6 Calibration procedure for E-field probes optimized for close near field evaluations in air Celoration date: February 23, 2018 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (Bi) The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)/C and humidity < 70% Calibration Equipment used (M&TE critical for calibration) Primary Standards Ð Cal Date (Certificate No.) Scheduled Calibration Power meter NRP 5N 104778 04-Apr-17 (Nn: 217-02521/02522) Apt-18 SNI 103244 Power sensor NRP-291 04-Apr-17 (No. 217-02521) Apr-18 Power sensor NRP-Z91 SN 103245 04-Apr-17 (No. 217-02525) Apr-18 Reference 20 dB Attenuator SN: \$5277 (20k) 07-Apr-17 (No. 217-02528) Apr-18 Reference Probe ER3DVB SN 2328 10-Oct-17 (No. ER3-2328, Oct17) Oct-18 DAE4 SN 789 2-Aug-17 (No. DAE4-789_Aug17) Aug-18 Secondary Standards 4D Check Eate (in house) Scheduled Chack Power meter E44108 SN: GB41293874 06-Apr-16 (in house check Jun-16) In house check, Jun-18 Power sensor E4412A 5N: MY41498087 06-Apr-16 (in house check Jun-16) In house check: Jun-18 Power sensor E4412A 5N 000110210 (6-Apr-16 (in house check Jun-16) In house check: Jun-18 RF generator HP 8648C SN: US3642U0170 04-Aug-99 (in house check Jun-1il) In house check: Jun-18 Notwork Analyzer HP 8753E SN: US37390585

 Network Analyzer HP 8753E
 SNL US37390585
 18-Oct-01 (in house check Oct-17)
 In house check Oct-18

 Calibrated by
 Name
 Function
 Signature

 Approved by
 Katja Pokovic
 Technical Manager
 Junu

 This calibration certificate shall not be reproduced except in full without written approval of the laboratory
 Signature
 Signature

Certificate No: ER3-2424_Feb18

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CAICI No. I20N01075-HAC RF

Calibration Laboratory of Schmid & Partner Engineering AG Zaughausstrasse 43, 8004 Zurich, Switzerland



s Schweizerischer Kalibrierdienst Service suisse d'étalonnage С Servizio avizzero di taratura s

Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Switz Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary N

NORMK, y.z DCP CF A, B, C, D	sensitivity in free space diode compression point crest factor (1/duty, cycle) of the RF signal modulation dependent linearization parameters
Polarization o	o rotation around probe axis
Polarization 3	9 rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., b = 0 is normal to probe axis.
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.0, November 2013

Methods Applied and Interpretation of Parameters:

- NORMX,y.z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz; R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor modia.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z; A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical (sotropy (3D deviation from (sotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset. The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle. The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: ER3-2424 Feb18

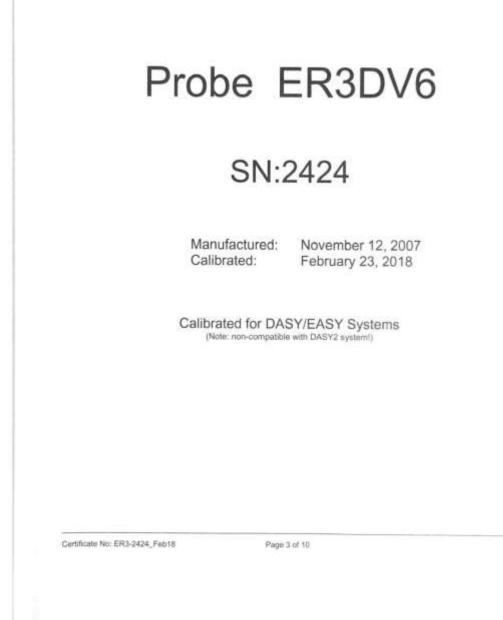
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ER3DV6-	Chi.	1.4.7.4
	- 2014	2424

February 23, 2018







ER3DV6 - SN:2424

February 23, 2018

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(Vim) ²)	1.46	1.51	1.82	±10.1 %
Norm (µV/(V/m) ²) DCP (mV) [®]	100.0	98.3	100.6	- 192.1 20

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	c	D dB	VR mV	Unc ^h (k=2)
0 CW	X	0.0	0.0	1.0	0.00	3.651	13.5%	
		Y	0.0	0.0	1.0		204.8	
		2	0.0	0.0	1.0		200.6	
10021- GSM-FDD (TDMA, GMSK) DAC	GSM-FDD (TDMA, GMSK)	×	21.68	99.9	28.7	9.39	106.2	\$2,2 %
		Y	19.41	99.7	28.8		111.3	
		Z	24.71	99.5	28.2		119.2	
10051- CAB	IEEE 802.11b WFi 2.4 GHz (DSSS, 11 Mbps)	X	8.35	84.6	25.4	3.60	146.9	±1.9 %
		Y	4.81	74.8	21.7		112.9	
1.00		Z	6.43	78.8	22.9		111.9	
10077- IEEE 802.11g WiFi 2.4 GHz CAB (DSSS/OFDM, 54 Mbps)	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 54 Mbps)	х	13.28	77.7	29.3	11.00	139.0	±3.8 %
		Y	11.65	73.4	26.9		100.8	
200.0		Z	11.41	72.1	25.6		99.2	
10172- CAD	LTE-TDD (SC-FDMA, 1 R8, 20 MHz, OPSK)	x	9.48	80.8	29.7	9.21	125.2	±3.8 %
		Y	9.49	81.9	30.6		134.1	-
		Z	10.82	83.6	30.5		136.8	
10173- LTE-TOD (SC-FDMA, 1 RB, 20 MHz, CAD 18-QAM)	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM)	х	9.87	81.2	29.9	9.48	125.1	12.5 %
		Y	10.11	83.1	31.3		134.2	
		Z	11.30	84.2	30.8		136.0	
10285- CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	х	16.69	99.5	40.3	12.49	96.6	\$2.5 %
		Y.	15.42	99.3	41.1		100.6	
		Z	17.91	99,9	-39.8		104.3	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

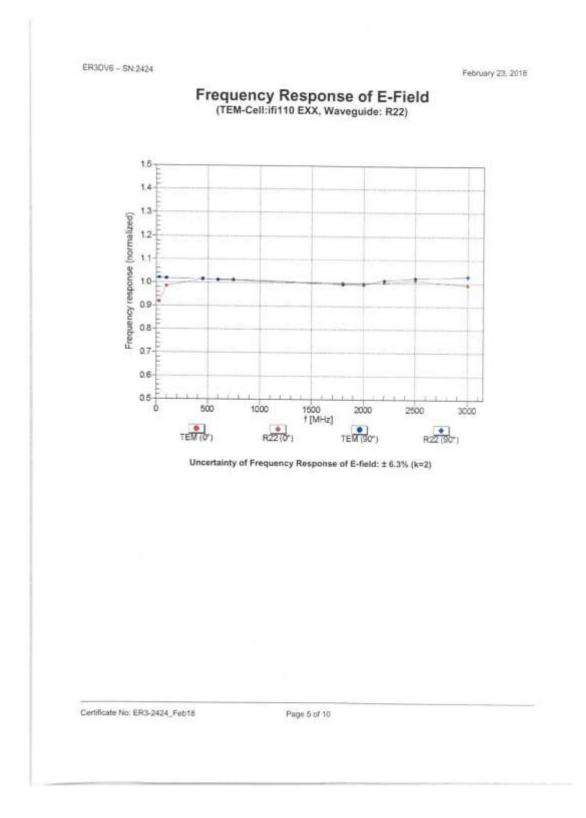
⁸ Numerical linearization parameter: uncertainty not required.
⁹ Uncertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: ER3-2424_Feb18

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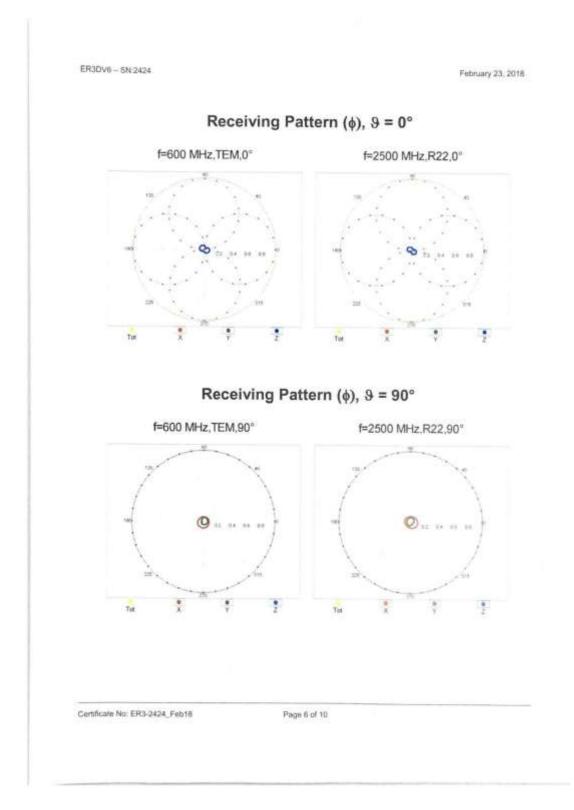






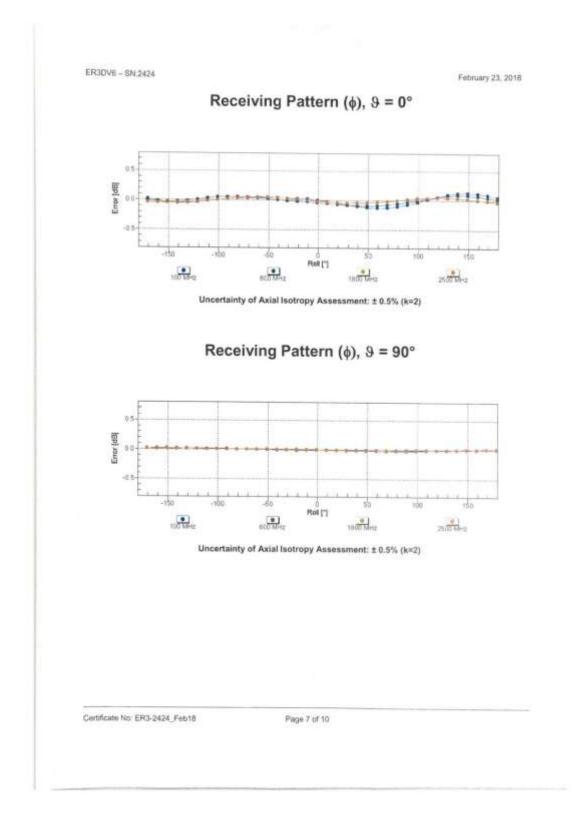






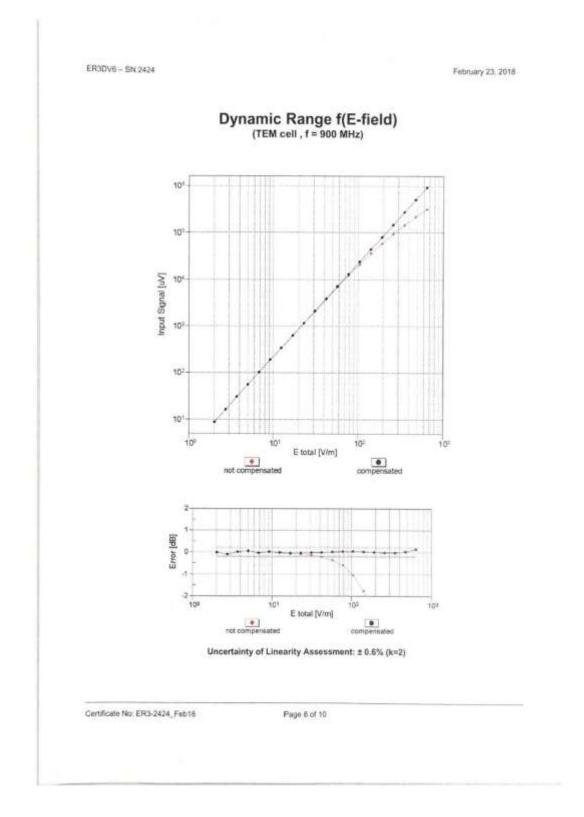


CAICT No. I20N01075-HAC RF





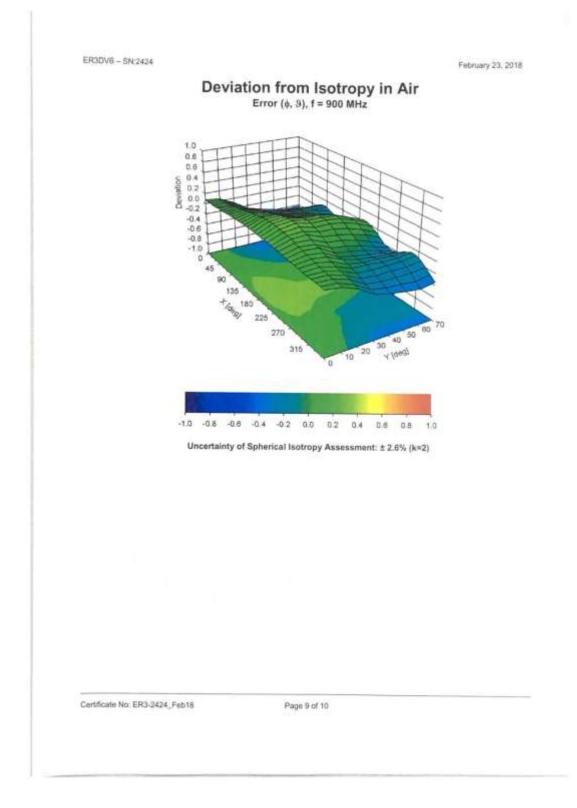




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ER3DV6 - SN:2424

February 23, 2018

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (*)	-11.2
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	537 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2424_Feb18

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ANNEX D: Dipole Calibration Certificate

Dipole 835 MHz

motified by the Swiss Accreditation e Swiss Accreditation Service is itiliateral Agreement for the reco			
e Swiss Accreditation Service is			creditation No.: SCS 0108
E Swiss Accreditation Service Is			Seditation No.: 0000 0100
	witten of estimation of	artificates	
ibialieral Adreament for the reco	gnition of calibration of		
ent CTTL (Auden)		Certificate No:	CD835V3-1165_Jul18
CALIBRATION CI	ERTIFICATE		
Dbject	CD835V3 - SN: 1	165	
Calibration procedure(s)	QA CAL-20.v6		
Contraction of the second second second	Calibration proces	dure for dipoles in air	
	- annean state of s		
Calibration date:	July 19, 2018		
		real standards, which realize the physical uni	a second second
All calibrations have been conducte	d in the closed laborator	y tacility: environment temperature (22 ± 3)*0	3 and humidity < 70 $\%$.
Calibration Equipment used (M&TE	critical for cs8bration)	Cal Date (Certificate No.)	Scheduled Calibration
Calibration Equipment used (M&TE Primary Standards Power meter NRP	critical for calibration)	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673)	Scheduled Calibration Apr-19
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291	critical for celebration) ID # SN: 104778 SN: 103244	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02573) 04-Apr-18 (No. 217-02672)	Scheduled Calibration Apr-19 Apr-19
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291	critical for celibration) ID # SN: 104778 SN: 103244 SN: 103245	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02573) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673)	Scheduled Calibration Apr-19 Apr-19 Apr-19
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuetor	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k)	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02573) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02673)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19
Calibration Equipment used (M&TE Primary Standards Power meter NEIP Power sensor NEIP-291 Power sensor NEIP-291 Reference 20 dB Attenuator Type-N mismatch combination	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02682) 04-Apr-18 (No. 217-02683)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Apr-19
Calibration Equipment used (M&TE Primary Standards Power meter NRP- Power sensor NRP-291 Reference 20 dB Attenuator Type-N mismatch combination Probe EF3DV3	eritical for calibration) 10.# SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 4013	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. EF3-4013, Mar18)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Apr-19 Mar-19
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuetor Type-N mismatch combination Probe EF3DV3 Probe H3DV6	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 4013 SN: 6065	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. EF3-4013, Mart8) 30-Dec-17 (No. H3-6065, Dec17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Apr-19 Mur-19 Dec-18
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuetor Type-N mismatch combination Probe EF3DV3 Probe H3DV6	eritical for calibration) 10.# SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 4013	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. EF3-4013, Mar18)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Apr-19 Mar-19
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuator Type-N mismatch combination	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 4013 SN: 6065	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. EF3-4013, Mart8) 30-Dec-17 (No. H3-6065, Dec17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mar-19 Mar-19 Dec-18 Jar-19 Scheduled Check
Calibration Equipment used (M&TE Primary Standards Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe F30V3 Probe H3DV6 DAE4	entitical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 5047.2 / 06327 SN: 6065 SN: 781 ID # SN: GB42420191	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02683) 04-Apr-18 (No. 217-02683) 05-Msr-18 (No. 217-02683) 05-Msr-18 (No. EF3-4013, Mar18) 30-Dec-17 (No. H5-6065, Dec17) 17-Jan-18 (No. DAE4-781_Jan18) Check Date (In house) 09-Oct-09 (In house check Oct-17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Apr-19 Mar-19 Mar-19 Dec-18 Jan-19 Scheduled Check In house check: Oct-29
Calibration Equipment used (M&TE Primary Standards Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe EF30V3 Probe EF30V3 Probe H3DV6 DAE4 Secondary Standards	entitical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.27/06327 SN: 6065 SN: 781 ID #	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02683) 05-Mar-18 (No. 217-02683) Check Date (In house) 09-Oct-09 (In house check Oct-17) 05-Jan-10 (In house check Oct-17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Apr-19 Mar-10 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20
Calibration Equipment used (M&TE Primary Standards Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismatch combination Probe EF30V3 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B	entitical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 5047.2 / 06327 SN: 6065 SN: 781 ID # SN: GB42420191	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. 217-02883) 05-Check Date (In house) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mar-19 Mar-19 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20 In house check: Oct-20
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuator Type-N mismetich combination Probe EF30V3 Probe H3DV8 DAE4 Secondary Standards Power meter Agilent 44198 Power meter Agilent 44198	eritical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5047.2 / 06327 SN: 6065 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37296597 SN: 832283/011	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. EF3-4013, Mar18) 30-Dec-17 (No. H3-6065, Dec17) 17-Jan-18 (No. DAE4-781_Jan18) Check Date (In house) 09-Oct-09 (In house check Oct-17) 05-Jan-10 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mur-19 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20 In house check: Oct-20 In house check: Oct-20 In house check: Oct-20
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Reference 20 dB Attenuator Type-N mismatch combination Probe EF3DV3 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 Power meter Agilent 44198 Power sensor HP E4412A Power sensor HP 8482A	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.2 / 06327 SN: 6065 SN: 781 ID # SN: G842420191 SN: US38485102 SN: US37295597	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. 217-02883) 05-Check Date (In house) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mar-19 Mar-19 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20 In house check: Oct-20
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuetor Type-N mismatch combination Probe EF3DV3 Probe H3DV6 DAE4 Secondary Standards Power meter Aglient 44198 Power sensor HP E4412A Power sensor HP E4412A RF generator R&S SMT-06	eritical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5047.2 / 06327 SN: 6065 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37296597 SN: 832283/011	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. EF3-4013, Mar18) 30-Dec-17 (No. H3-6065, Dec17) 17-Jan-18 (No. DAE4-781_Jan18) Check Date (In house) 09-Oct-09 (In house check Oct-17) 05-Jan-10 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mur-19 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20 In house check: Oct-20 In house check: Oct-20 In house check: Oct-20
Calibration Equipment used (M&TE Primary Standards Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismäch combination Probe H3DV6 DAE4 Secondary Standards Power metor Aglient 4419B Power sensor HP 8482A RF generator R&S SMT-06 Network Analyzor Agilant EB35BA	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.27.06327 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 632283/011 SN: US41080477 Name	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02683) 05-Msr-18 (No. 217-02683) 05-Msr-18 (No. 217-02683) 05-Msr-18 (No. 217-02683) 05-Msr-18 (No. 217-02683) 05-Msr-18 (No. 217-02683) 05-Msr-18 (No. 217-02683) 05-Dec-17 (No. H3-6065, Dec17) 17-Jan-18 (No. DAE4-781_Jan18) Check Date (In house) 09-Oct-09 (In house check Oct-17) 05-Jan-10 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 27-Aug-12 (In house check Oct-17) 31-Mar-14 (In house check Oct-17) Function	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mur-10 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20
Calibration Equipment used (M&TE Primary Standards Power meter NRP Power sensor NRP-291 Power sensor NRP-291 Reference 20 dB Attenuetor Type-N mismatch combination Probe EF3DV3 Probe H3DV6 DAE4 Secondary Standards Power meter Aglient 44198 Power sensor HP E4412A Power sensor HP E4412A RF generator R&S SMT-06	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5058 (20k) SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US3848545102 SN: US3848545102 SN: US3848545102 SN: US3848545102 SN: US3848545102 SN: US3848545454545454545454545454545454545454	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02673) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02883) 05-Msr-18 (No. EF3-4013, Mar18) 30-Dec-17 (No. H5-6065, Dec17) 17-Jan-18 (No. DAE4-781_Jan18) Check Date (In house) 09-Oct-09 (In house check Oct-17) 05-Jan-10 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 27-Aug-12 (In house check Oct-17) 31-Mar-14 (In house check Oct-17)	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mur-10 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20
Calibration Equipment used (M&TE Primary Standards Power sensor NRP-Z91 Power sensor NRP-Z91 Reference 20 dB Attenuator Type-N mismäch combination Probe H3DV6 DAE4 Secondary Standards Power metor Aglient 4419B Power sensor HP 6442A RF generator R&S SMT-06 Network Analyzor Agilent EB35BA	critical for calibration) ID # SN: 104778 SN: 103244 SN: 103245 SN: 5058 (20k) SN: 5047.27.06327 SN: 6065 SN: 781 ID # SN: GB42420191 SN: US38485102 SN: US37295597 SN: 632283/011 SN: US41080477 Name	Cal Date (Certilicate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672) 04-Apr-18 (No. 217-02873) 04-Apr-18 (No. 217-02882) 04-Apr-18 (No. 217-02883) 05-Mar-18 (No. 217-02883) 05-Oct-09 (In house check Oct-17) 05-Jan-10 (In house check Oct-17) 09-Oct-09 (In house check Oct-17) 27-Aug-12 (In house check Oct-17) 31-Mar-14 (In house check Oct-17) Function Laboratory Technician	Scheduled Calibration Apr-19 Apr-19 Apr-19 Apr-19 Mur-10 Dec-18 Jan-19 Scheduled Check In house check: Oct-20 In house check: Oct-20
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Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

 ANSI-C63.19-2011 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement, The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.1
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	108.7 V/m = 40.72 dBV/m
Maximum measured above low end	100 mW input power	108.6 V/m = 40.72 dBV/m
Averaged maximum above arm	100 mW input power	108.7 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	16.4 dB	40.0 Ω - 9.2 jΩ
835 MHz	25.5 dB	53.7 Ω + 4.0 jΩ
880 MHz	17.8 dB	60.3 Ω - 9.8 jΩ
900 MHz	16.5 dB	51.6 Ω - 15.3 jΩ
945 MHz	21.7 dB	43.9 Ω + 4.8 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

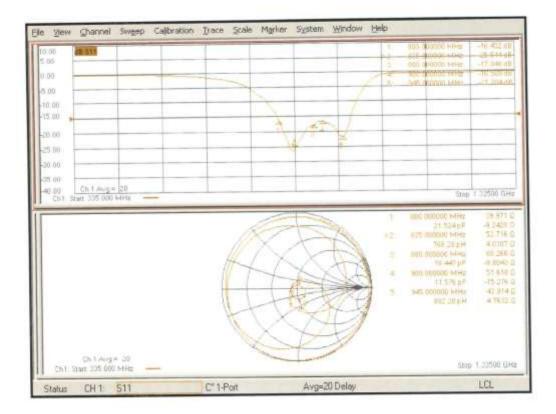
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Impedance Measurement Plot



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DASY5 E-field Result

Date: 19.07.2018

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1165

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ S/m, $z_c = 1$; $\rho = 0$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63,19-2011)

DASY52 Configuration:

- Probe: EF3DV3 5N4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 05.03.2018
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 17.01.2018
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.1(1476); SEMCAD X 14.6.11(7439)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 130.9 V/m; Power Drift = 0.02 dB Applied MIF = 0.00 dB RF audio interference level = 40.73 dBV/m Emission category: M3

 MIF scaled E-field

 Grid 1 M3
 Grid 2 M3
 Grid 3 M3

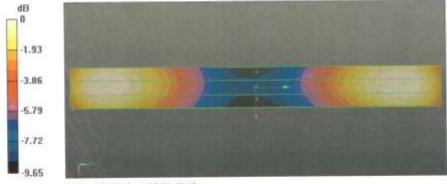
 40.28 dBV/m
 40.72 dBV/m
 40.67 dBV/m

 Grid 4 M4
 Grid 5 M4
 Grid 6 M4

 35.61 dBV/m
 35.96 dBV/m
 35.94 dBV/m

 Grid 7 M3
 Grid 8 M3
 Grid 9 M3

 40.41 dBV/m
 40.73 dBV/m
 40.67 dBV/m



0 dB = 108.7 V/m = 40.72 dBV/m

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S Schweizerischer Kalibrierdienst

Dipole 1880 MHz

Schmid & Partner

Calibration Laboratory of

attilateral Agreement for the rec	ognition of calibration of	ornncates	
ent CTTL (Auden)			: CD1880V3-1149_Jul18
ALIBRATION C	ERTIFICATE		
Object	CD1880V3 - SN:		
			6
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	dure for dipoles in air	
Calibration date:	July 19, 2018		
		obability are given on the following pages an y facility: environment temperature $(22 \pm 3)^{\circ}$	
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All calibrations have been conduct Calibration Equipment used (M&T Primary Standards	ted in the closed laborator E critical for calibration)	y facility: environment temperature (22 ± 3) 1	nd are part of the contificate.
All calibrations have been conduct Calibration Equipment used (M&T Primary Standards Power meter NRP	ted in the closed laborator E critical for calibration)	y facility: environment temperature (22 ± 3)*1 Cal Date (Certificate No.) 04-Apr-18 (No. 217-02672/02673) 04-Apr-18 (No. 217-02672)	d are part of the certificate. C and humidity < 70%. Scheduled Calibration
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Certificate No: CD1880V3-1149_Jul18

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étalonnage C Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

S

S

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

- [1] ANSI-C63.19-2011
 - American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms, x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY5	V52.10.1
HAC Test Arch	
15 mm	
dx, dy = 5 mm	
1880 MHz ± 1 MHz	
< 0.05 dB	
	HAC Test Arch 15 mm dx, dy = 5 mm 1880 MHz ± 1 MHz

Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	89.8 V/m = 39.06 dBV/m
Maximum measured above low end	100 mW input power	89,3 V/m = 39.02 dBV/m
Averaged maximum above arm	100 mW input power	89.5 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
1730 MHz	23.9 dB	53.9 Ω + 5.4 jΩ
1880 MHz	22.5 dB	54.7 <u>1</u> 2 + 6.3 j <u>1</u> 2
1900 MHz	23.4 dB	55.6 Ω + 4.5 jΩ
1950 MHz	30.3 dB	52.9 Ω - 1.3 jΩ
2000 MHz	21.3 dB	44.2 Ω + 5.7 JΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

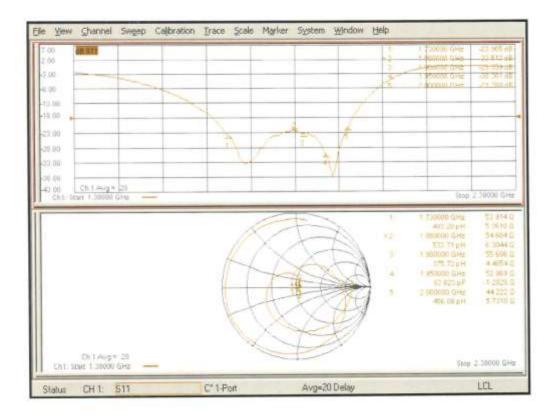
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



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DASY5 E-field Result

Date: 19.07.2018

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type; CD1880V3; Serial: CD1880V3 - SN: 1149

Communication System: UID 0 - CW : Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_c = 1$; $\rho = 0$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

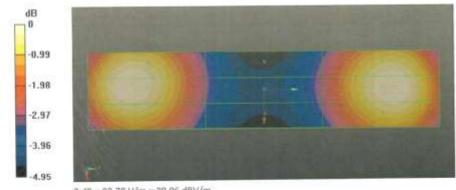
- Probe: EF3DV3 5N4013; ConvF(1, 1, 1) @ 1880 MHz; Calibrated: 05.03.2018
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 5n781; Calibrated: 17.01.2018
- · Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.1(1476); SEMCAD X 14.6.11(7439)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 160,1 V/m; Power Drift = -0.04 dB Applied MIF = 0.00 dB RF audio interference level = 39.06 dBV/m Emission category: M2

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
38.67 dBV/m	39.06 dBV/m	39.01 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
36 dBV/m	36.15 dBV/m	36.1 dBV/m
2000000000	Grid 8 M2 39.02 dBV/m	Grid 9 M2 38.91 dBV/m



0 dB = 89.78 V/m = 39.06 dBV/m

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ANNEX E: UID Specification

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Name:	GSM-FDD (TOMA, GMSK)	
Group: UID:	GSM 10021-DAC	
PAR: 1 MFL ²	9.3948 3.6348	
Blandard Paterence Category: Modulation: Frequency Band:	ETBI TS 100 909 V8.9.0 (2005-01) FCC OET KDB 941225, D03 and D04 Periodic putsed modulation GMSK GSM 450 (400.4 - 457.6 MHz) GSM 450 (419.8 - 486.0 MHz) GSM 750 (496.0 - 716.0 MHz) GSM 750 (747.0 - 783.0 MHz) GSM 750 (747.0 - 783.0 MHz) F-GSM 900 (880.0 - 915.0 MHz) E-GSM 900 (880.0 - 915.0 MHz) DC5 1800 (171.0 - 915.0 MHz) DC5 1800 (171.0 - 915.0 MHz) E-GSM 900 (1850.0 - 101.5 MHz) DC5 1800 (115.0 0 - 101.5 MHz) E-GSM 900 (1850.0 - 101.0 MHz)	
Detailed Specification:	Active Slot: TN0 Data: PN9 continuous Frame: composed out of 8 Slots Multiframa: 28th (IDLE) Frame set blank	
Bandwidth: Integration Time:	Sintype 8. timing: Normal burst for GMSK 0.2 MHz 120.0 ms	

PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)"
 Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for
the same communication system (same UID and version).

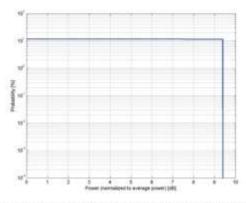
UID Specification Sheet UID 10021-DAC page 1/2

16.11.2016

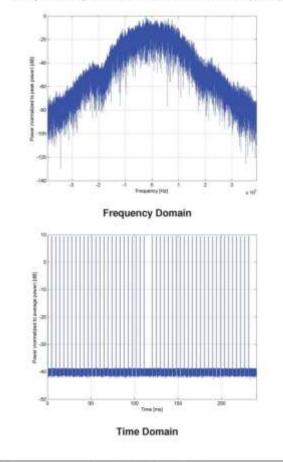




Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)



UID Specification Sheet

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16.11.2016





Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Name: UMTS-FDD (WCDMA) Group: WCDMA UID: 10011-CAB PAR: 1 2.91 dB MIF: 2 -27.23 dB 3GPP TS 25.141 Annex A Standard Reference: FCC OET KDB 941225 D01 SAR test for 3G devices v02 Category: Random amplitude modulation Modulation: QPSK Frequency Band: Band 1, UTRA/FDD (1920.0-1980.0 MHz, 20000) Band 2, UTRA/FDD (1850.0-1910.0 MHz, 20001) Band 3, UTRA/FDD (1710.0-1785.0 MHz, 20002) Band 4, UTRA/FDD (1710.0-1755.0 MHz, 20003) Band 5, UTRA/FDD (824.0-849.0 MHz, 20004) Band 6, UTRA/FDD (830.0-840.0 MHz, 20005) Band 7, UTRA/FDD (2500.0-2570.0 MHz, 20006) Band 8, UTRA/FDD (880.0-915.0 MHz, 20007) Band 9, UTRA/FDD (1749.9-1784.9 MHz, 20008) Band 10, UTRA/FDD (1710.0-1770.0 MHz, 20009) Band 11, UTRA/FDD (1427.9-1452.9 MHz, 20010) Band 12, UTRA/FDD (698.0-716.0 MHz, 20011) Band 13, UTRA/FDD (777.0-787.0 MHz, 20012) Band 14, UTRA/FDD (788.0-798.0 MHz, 20013) Band 19, UTRA/FDD (830.0-845.0 MHz, 20130) Band 20, UTRA/FDD (832.0-862.0 MHz, 20131) Band 21, UTRA/FDD (1447.9-1462.9 MHz, 20132) Band 22, UTRA/FDD (3410.0-3490.0 MHz, 20217) Band 25, UTRA/FDD (1850.0-1915.0 MHz, 20218) Band 26, UTRA/FDD (814.0-849.0 MHz, 20219) Detailed Specification: Dedicated Channel Type: RMC Bitrate: 12.2 kbps DPDCH: 60 kbps DPCCH: 15 kbps DPCCH/DPDCH power ratio: -5.46 dB Bandwidth: 5.0 MHz Integration Time: 100.0 ms

 PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)"
 Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for the same communication system (same UID and version).

UID Specification Sheet

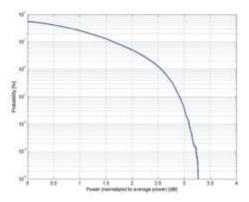
UID 10011-CAB page 1/2

16.01.2014

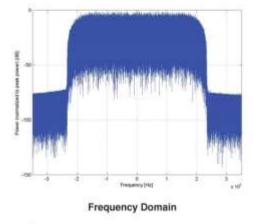


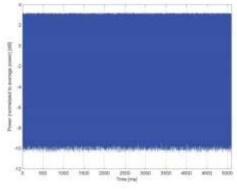


Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)





Time Domain

UID 10011-CAB page 2/2

16.01.2014

UID Specification Sheet





Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Name:	LTE-FDD (SC-FDMA, 1 R8, 10 MHz, 16-QAM)	
Group:	LTE-FDD	
UID	10176-CAE	
ana a		
PAR:	6.52dB	
MIF-	-9.76 dB	
Standard Reference:	3GPP / ETSI TS 136,101 V8.4.0	
	3GPP / ETSI TS 136,213 V8.4.0	
	FCC DET KDB 941225 D05 SAR for LTE Devices v01	
Category:	Random amplitude modulation	
Modulation:	16-QAM	
Frequency Band:	Band 1, E-UTRA/FDD (1920.0 - 1960.0 MHz)	
	Band 2, E-UTRA/FDD (1850.0 + 1910.0 MHz)	
	Band 3, E-UTRA/FDD (1710.0 - 1765.0 MHz) Band 4, E-UTRA/FDD (1710.0 - 1755.0 MHz)	
	Band 6, E-UTRA/FDD (824.0 - 849.0 MHz)	
	Band 5, E-UTRA/FDD (830.0 - 840.0 MHz)	
	Band 7, E-UTRA/FDD (2500.0 - 2570.0 MHz)	
	Band 8, E-UTRA/FDD (880.0 - 915.0 MHz)	
	Band 9, E-UTRA/FDD (1749.9 - 1784.9 MHz)	
	Band 10, E-UTRA/FDD (1710.0 - 1770.0 MHz)	
	Band 11, E-UTRA/FDD (1427.9 - 1447.9 MHz)	
	Band 12, E-UTRA/FDD (699.0 - 710.0 MHz)	
	Band 13, E-UTPA/FDD (777.0 - 787.0 MHz)	
	Band 14, E-UTRA/FDD (788.0 - 798.0 MHz)	
	Band 17, E-UTRA/FDD (704.0 - 716.0 MHz)	
	Band 18, E-UTRA/FDD (815.0 - 830.0 MHz)	
	Band 19, E-UTRA/FDD (830.0 - 845.0 MHz)	
	Band 20, E-UTRA/FDD (832.0 - 862.0 MHz)	
	Band 21, E-UTRA/FDD (1447.9 - 1462.9 MHz)	
	Band 22, E-UTRA/FDD (3410.0 - 3490.0 MHz)	
	Band 23, E-UTRA/FDD (2000.0 - 2020.0 MHz) Band 24, E-UTRA/FDD (1626.5 - 1660.5 MHz)	
	Band 25, E-UTRA/FDD (1850.0 - 1915.0 MHz)	
	Band 26 E-UTRA/FDD (814.0 - 849.0 MHz)	
	Band 27 E-UTRA/FDD (807.0 - 824.0 MHz)	
	Band 28 E-UTRA/FDD (703.0 - 748.0 MHz)	
	Band 30, E-UTRA/FDD (2305.0 - 2315.0 MHz)	
	Band 65, E-UTRA/FDD (1920.0 - 2010.0 MHz)	
	Band 66, E-UTRA/FDD (1710.0 - 1780.0 MHz)	
	Band 68, E-UTRA/FDD (698.0 - 728.0 MHz)	
	Band 70, E-UTRA/FDD (1695.0 - 1710.0 MHz)	
	Band 71, E-UTRA/FDD (663.0 - 698.0 MHz)	
	Validation band (0.0 - 6000.0 MHz)	
Detailed Specification:	Modulation Scheme: SC-FDMA	
11.5453463473 8 7354215458634294	Number of PUSCHs: 1	
	Settings for Subframe #0 to #9:	
	Modulation Scheme: QPSK	
	Data Type: UL-SCH	
	Number RB: 1	
	Transport Block Size: 258	
	TBS Index: 14	
	MCS Index: 15	
Bandwidth:	Data Type: PNB 10.0 MHz	
Integration Time:	10.0 ms	
transfer and the state of the s		

PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)" Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for the same communication system (same UID and version).

UID Specification Sheet

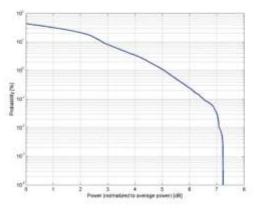
UID 10176-CAE page 1/2

27.07.2017

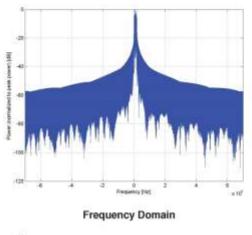


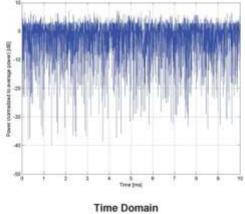


Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)





UID Specification Sheet

UID 10176-CAE page 2/2





Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Name:	LTE-FDD (SC-FDMA, 1 R8, 20 MHz, 16-QAM)	
Group:	LTE-EDD	
UID	10170-CAD	
olo.	10170-0702	
PAR:	6.52 dB	
MIE-#	-9.76 dB	
Standard Referencie:	3GPP / ETSI TS 136.101 VE 4.0	
	30PP / ETSI TS 136,213 V8.4.0	
	FCC OET KDB 941225 D05 SAR for LTE Devices v01	
Category:	Pandom amplitude modulation	
Modulation:	16-QAM	
Frequency Band:	Band 1, E-UTRA/FDD (1920.0 - 1980.0 MHz)	
rrequerray dama.	Band 2, E-UTRA/FDD (1850.0 - 1910.0 MHz)	
	Band 3, E-UTRA/FDD (1500.0 - 1785.0 MHz)	
	Band 4, E-UTRA/FDD (1710.0 - 1756.0 MHz)	
	Band 7, E-UTRA/FDD (2500.0 - 2570.0 MHz)	
	Band 9, E-UTRA/FDD (1749.9 - 1784.9 MHz)	
	Band 10, E-UTRA/FDD (1710.0 - 1770.0 MHz)	
	Band 20, E-UTRA/FDD (832.0 - 862.0 MHz)	
	Band 22, E-UTRA/FDD (3410.0 - 3490.0 MHz)	
	Band 23, E-UTRA/FDD (2000.0 - 2020.0 MHz)	
	Band 25, E-UTRA/FDD (1850.0 - 1915.0 MHz)	
	Band 28 E-UTRA/FDD (703.0 - 748.0 MHz)	
	Band 65, E-UTRA/FOD (1920.0 - 2010.0 MHz)	
	Band 66, E-UTRA/FDD (1710.0 - 1780.0 MHz)	
	Band 70, E-UTRA/FDD (1695.0 - 1710.0 MHz)	
	Band 71, E-UTRA/FDD (663.0 - 698.0 MHz)	
	Validation band (0.0 - 6000.0 MHz)	
	vandaduju bilina (u.o dobulu arma)	
Detailed Specification:	Modulation Scheme: SC-FDMA	
	Number of PUSCHs; 1	
	Settings for Subframe #0 to #9:	
	Modulation Scheme: 16QAM	
	Data Type: UL-SCH	
	Number RB: 1	
	Transport Block Size: 258	
	TBS Index: 14	
	MCS Index: 15	
	Data Type: PN9	
Bandwidth	20.0 MHz	
Integration Time:		
utedration (me)	10.0 ms	

PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)" Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for the same communication system (same UID and version).

UID Specification Sheet

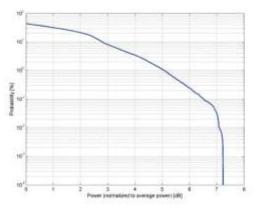
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27.07.2017

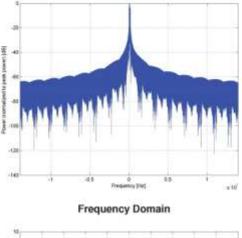


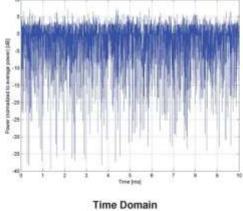


Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)





UID Specification Sheet

UID 10170-CAD page 2/2

27.07.2017





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Name:	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)
Group:	WLAN
UID:	10061-CAB
PAR: 1	3.60 dB
MIF: 2	-2.02 dB
Standard Reference:	IEEE 802.11b-1999, Part 11, FCC SAR meas for 802 11 a b g v01r02 (248227 D01)
Category:	Random amplitude modulation
Modulation:	DQPSK
Frequency Band:	WLAN 2.4GHz (2412.0-2484.0 MHz, 20230)
Detailed Specification:	Data Rate: 11 Mbps
	Spreading, Coding: CCK
	PPDU format: Long Preamble & Heading
	PSDU Length: 1024
Bandwidth:	PSDU Data: PN9 20.0 MHz
Integration Time:	1.5 ms

 PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)"
 Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for the same communication system (same UID and version).

UID Specification Sheet

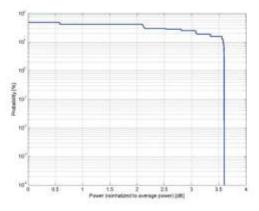
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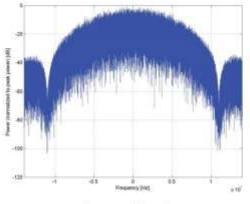




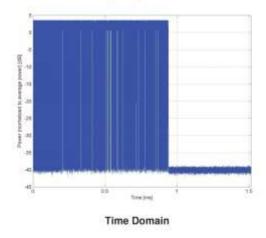
Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)



Frequency Domain



UID Specification Sheet

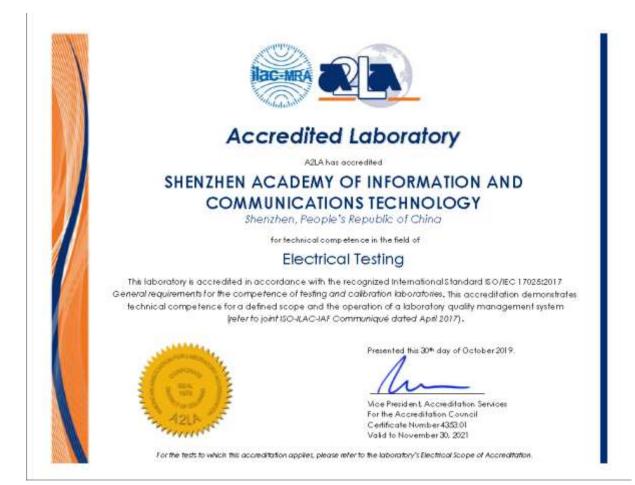
UID 10061-CAB page 2/2

26.11.2014





ANNEX F: Accreditation Certificate



END OF REPORT